SGLS216 - NOVEMBER 2003

- **Controlled Baseline** 
  - One Assembly/Test Site, One Fabrication
- **Extended Temperature Performance of** -40°C to 125°C
- **Enhanced Diminishing Manufacturing** Sources (DMS) Support
- **Enhanced Product-Change Notification**
- Qualification Pedigree†
- **ESD Protection Exceeds 2000 V Per** MIL-STD-883. Method 3015: Exceeds 150 V (TLC2252/52A) and 100 V (TLC2254/54A) Using Machine Model (C = 200 pF, R = 0)
- † Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

### **Output Swing Includes Both Supply Rails**

- Low Noise . . . 19 nV/ $\sqrt{\text{Hz}}$  Typ at f = 1 kHz
- Low Input Bias Current . . . 1 pA Typ
- Fully Specified for Both Single-Supply and **Split-Supply Operation**
- Very Low Power . . . 35 μA Per Channel Typ
- Common-Mode Input Voltage Range Includes Negative Rail
- Low Input Offset Voltage 850  $\mu$ V Max at  $T_{\Delta} = 25^{\circ}$ C (TLC225xA)
- Macromodel Included
- Performance Upgrades for the TS27L2/L4 and TLC27L2/L4

### description

The TLC2252 and TLC2254 are dual and quadruple operational amplifiers from Texas Instruments. Both devices exhibit rail-to-rail output performance for increased dynamic range in single- or split-supply applications. The TLC225x family consumes only 35 µA of supply current per channel. This micropower operation makes them good choices for battery-powered applications. The noise performance has been dramatically improved over previous generations of CMOS amplifiers. Looking at Figure 1, the TLC225x has a noise level of 19 nV/ $\sqrt{Hz}$  at 1kHz; four times lower than competitive micropower solutions.

The TLC225x amplifiers, exhibiting high input impedance and low noise, are excellent for small-signal conditioning for high-impedance sources, such as piezoelectric transducers. Because of the micropower dissipation levels, these devices work well in hand-held monitoring and remote-sensing applications. In addition, the rail-to-rail output feature with single or split

# **EQUIVALENT INPUT NOISE VOLTAGE**

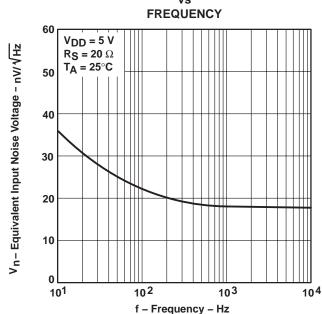


Figure 1

supplies makes this family a great choice when interfacing with analog-to-digital converters (ADCs). For precision applications, the TLC225xA family is available and has a maximum input offset voltage of 850 µV. This family is fully characterized at 5 V and  $\pm 5$  V.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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SGLS216 - NOVEMBER 2003

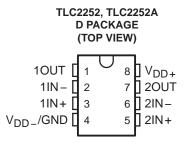
### description/ordering information (continued)

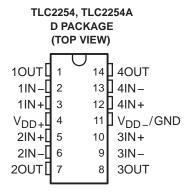
The TLC2252/4 also makes great upgrades to the TLC27L2/L4 or TS27L2/L4 in standard designs. They offer increased output dynamic range, lower noise voltage, and lower input offset voltage. This enhanced feature set allows them to be used in a wider range of applications. For applications that require higher output drive and wider input voltage ranges, see the TLV2432 and TLV2442 devices. If the design requires single amplifiers, please see the TLV2211/21/31 family. These devices are single rail-to-rail operational amplifiers in the SOT-23 package. Their small size and low power consumption, make them ideal for high density, battery-powered equipment.

### ORDERING INFORMATION

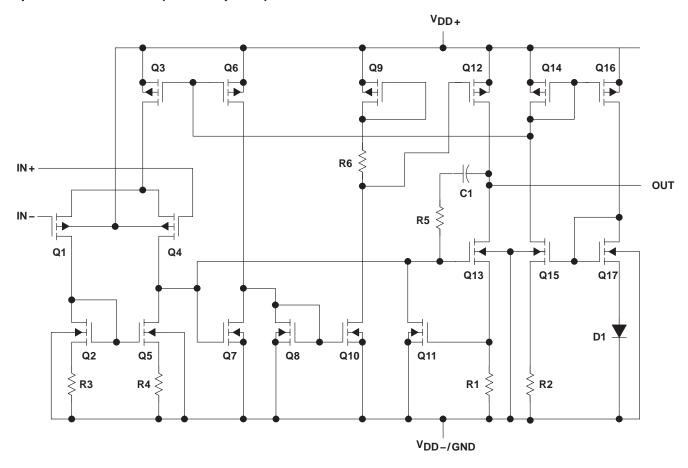
TA	V <sub>IO</sub> max AT 25°C	PACK	AGE†	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	850 μV	SOIC (D)	Tape and reel	TLC2252AQDREP	2252AE
400C to 4050C	1550 μV	SOIC (D)	Tape and reel	TLC2252QDREP	2252EP
-40°C to 125°C	850 μV	SOIC (D)	Tape and reel	TLC2254AQDREP	TLC2254AEP
	1550 μV	SOIC (D)	Tape and reel	TLC2254QDREP	TLC2254EP

<sup>†</sup> Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.





### equivalent schematic (each amplifier)



ACTUAL DEVICE COMPONENT COUNT¹           COMPONENT         TLC2252         TLC2254           Transistors         38         76           Resistors         30         56           Diodes         9         18								
COMPONENT	TLC2252	TLC2254						
Transistors	38	76						
Resistors	30	56						
Diodes	9	18						
Capacitors	3	6						

<sup>†</sup> Includes both amplifiers and all ESD, bias, and trim circuitry

### TLC225x-EP, TLC225xA-EP Advanced LinCMOS™ RAIL-TO-RAIL VERY LOW-POWER OPERATIONAL AMPLIFIERS

SGLS216 - NOVEMBER 2003

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>DD+</sub> (see Note 1)	
Supply voltage, V <sub>DD</sub> (see Note 1)	
Differential input voltage, V <sub>ID</sub> (see Note 2)	±16 V
Input voltage, V <sub>I</sub> (any input, see Note 1)	
Input current, I <sub>I</sub> (each input)	±5 mA
Output current, I <sub>O</sub>	±50 mA
Total current into V <sub>DD+</sub>	±50 mA
Total current out of V <sub>DD</sub>	±50 mA
Duration of short-circuit current at (or below) 25°C (see Note 3)	unlimited
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range, T <sub>A</sub> : Q suffix	–40°C to 125°C
Storage temperature range, T <sub>stq</sub>	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to the midpoint between V<sub>DD+</sub> and V<sub>DD-</sub>.

- 2. Differential voltages are at IN+ with respect to IN-. Excessive current flows when input is brought below V<sub>DD</sub> 0.3 V.
- 3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

### **DISSIPATION RATING TABLE**

PACKAGE	$T_{\mbox{A}} \le 25^{\circ}\mbox{C}$ Power rating	DERATING FACTOR ABOVE T <sub>A</sub> = 25°C	T <sub>A</sub> = 70°C POWER RATING	T <sub>A</sub> = 85°C POWER RATING	T <sub>A</sub> = 125°C POWER RATING
D-8	724 mW	5.8 mW/°C	464 mW	377 mW	144 mW
D-14	950 mW	7.6 mW/°C	608 mW	450 mW	190 mW

### recommended operating conditions

	MIN	MAX	UNIT
Supply voltage, V <sub>DD±</sub>	±2.2	±8	V
Input voltage range, V <sub>I</sub>	$V_{DD-}$	V <sub>DD+</sub> -1.5	V
Common-mode input voltage, V <sub>IC</sub>	V <sub>DD</sub> _	V <sub>DD+</sub> -1.5	V
Operating free-air temperature, T <sub>A</sub>	-40	125	°C

<sup>‡</sup>Referenced to 2.5 V



SGLS216 - NOVEMBER 2003

### electrical characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$ (unless otherwise noted)

	PARAMETER	TEST CON	DITIONS	T. +	TL	C2252-E	Р	TLC	2252A-	EP	
	PARAMETER	I EST CON	DITIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
\/. <b>-</b>	Input offset voltage			25°C		200	1500		200	850	μV
VIO	input offset voltage			Full range			1750			1000	μν
αΛΙΟ	Temperature coefficient of input offset voltage			25°C to 125°C		0.5			0.5		μV/°C
	Input offset voltage long-term drift (see Note 4)	$V_{DD\pm} = \pm 2.5 \text{ V},$ $V_{O} = 0,$	$V_{IC} = 0,$ R <sub>S</sub> = 50 $\Omega$	25°C		0.003			0.003		μV/mo
IIO	Input offset current			25°C		0.5	60		0.5	60	рA
10	input onset current			Full range			1000			1000	P/
I <sub>IB</sub>	Input bias current			25°C		1	60		1	60	pА
,ID	mpar blad carront			Full range			1000			1000	P/ t
V	Common-mode input	Pa = 50 O	1\/ 1<5 m\/	25°C	0 to 4	-0.3 to 4.2		0 to 4	-0.3 to 4.2		٧
VICR	voltage range	KS = 50 12,		Full range	0 to 3.5			0 to 3.5			V
		$I_{OH} = -20  \mu A$		25°C		4.98			4.98		
Vou	High-level output	I <sub>OH</sub> = -75 μA		25°C	4.9	4.94		4.9	4.94		V
VOH	voltage	ΙΟΗ = -75 μΑ		Full range	4.8			4.8		38	V
		$I_{OH} = -150  \mu A$		25°C	4.8	4.88		4.8	4.88		
		$V_{IC} = 2.5 V$ ,	$I_{OL} = 50 \mu A$	25°C		0.01			0.01		
	Low-level output	V <sub>IC</sub> = 2.5 V,	I <sub>OL</sub> = 500 μA	25°C		0.09	0.15		0.09	0.15	
$V_{OL}$	voltage	V <sub>1</sub> C = 2.0 V,	-10L = 000 μ/τ	Full range			0.15			0.15 0.15 7 1	V
	•	V <sub>IC</sub> = 2.5 V,	$I_{OI} = 4 \text{ mA}$	25°C		0.8	1		0.7		
		10 =:0 :,	-OL	Full range			1.2			1.2	
	Large-signal differential	V <sub>IC</sub> = 2.5 V,	R <sub>L</sub> = 100 kه	25°C	100	350		100	350		
$A_{VD}$	voltage amplification	$V_0 = 1 \text{ V to 4 V}$		Full range	10			10			V/mV
			$R_L = 1 M\Omega^{\ddagger}$	25°C		1700			1700		
<sup>r</sup> id	Differential input resistance			25°C		1012			1012		Ω
r <sub>ic</sub>	Common-mode input resistance			25°C		10 <sup>12</sup>			10 <sup>12</sup>		Ω
c <sub>ic</sub>	Common-mode input capacitance	f = 10 kHz,	f = 10 kHz,	25°C		8			8		pF
z <sub>0</sub>	Closed-loop output impedance	f = 25 kHz,	A <sub>V</sub> = 10	25°C		200			200		Ω
CMRR	Common-mode rejection ratio	$V_{IC} = 0 \text{ to } 2.7 \text{ V},$ RS = 50 $\Omega$	V <sub>O</sub> = 2.5 V,	25°C Full range	70 70	83		70 70	83		dB
ksvr	Supply-voltage rejection ratio	$V_{DD} = 4.4 \text{ V to } 1$		25°C	80	95		80	95		dB
- 1.5	(ΔV <sub>DD</sub> /ΔV <sub>IO</sub> )	$V_{IC} = V_{DD}/2$ ,	No load	Full range	80			80			
I <sub>DD</sub>	Supply current	V <sub>O</sub> = 2.5 V,	No load	25°C		70	125		70	125	μΑ
-טט	Cappiy Curront	10 = 2.5 v,	110 1000	Full range			150			150	μΛ

Full range is -40°C to 125°C for Q suffix.

NOTE 4: Typical values are based on the input offset voltage shift observed through 500 hours of operating life test at  $T_A = 150^{\circ}C$  extrapolated to  $T_A = 25^{\circ}C$  using the Arrhenius equation and assuming an activation energy of 0.96 eV.



<sup>‡</sup>Referenced to 2.5 V

# TLC225x-EP, TLC225xA-EP Advanced LinCMOS™ RAIL-TO-RAIL **VERY LOW-POWER OPERATIONAL AMPLIFIERS**

SGLS216 - NOVEMBER 2003

### operating characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

	ADAMETED	TEST SOUD	ITIONIO	- +	TLO	C2252-E	Р	TLC	2252A-	EP	LINUT
P.	ARAMETER	TEST COND	ITIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	TYP	P MAX 2 6 9 7 1 6 % 2 0 3 3	UNIT
	Class nata at south	V- 05 V to 25 V		25°C	0.07	0.12		0.07	0.12		
SR	Slew rate at unity gain	$V_O = 0.5 \text{ V to } 3.5 \text{ V},$ $R_L = 100 \text{ k}\Omega^{\ddagger},$	$C_L = 100 \text{ pF}^{\ddagger}$	Full range	0.05			0.05			V/μs
.,	Equivalent input	f = 10 Hz		25°C		36			36		nV/√ <del>Hz</del>
Vn	noise voltage	f = 1 kHz		25°C		19			19		nv/√HZ
\/	Peak-to-peak	f = 0.1 Hz to 1 Hz		25°C		0.7			0.7		
V <sub>N(PP)</sub>	equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1			1.1		μV
In	Equivalent input noise current			25°C		0.6			0.6		fA√Hz
TUD . N	Total harmonic	$V_0 = 0.5 \text{ V to } 2.5 \text{ V},$	A <sub>V</sub> = 1	0500		0.2%			0.2%		
THD + N	distortion plus noise	$f = 10 \text{ kHz},$ $R_L = 50 \text{ k}\Omega^{\ddagger}$	A <sub>V</sub> = 10	25°C		1%			1%		
	Gain-bandwidth product	f = 50  kHz, $C_L = 100 \text{ pF}^{\ddagger}$	$R_L = 50 \text{ k}\Omega^{\ddagger}$ ,	25°C		0.2			0.2		MHz
ВОМ	Maximum output- swing bandwidth	$V_{O(PP)} = 2 V,$ $R_L = 50 \text{ k}\Omega^{\ddagger},$	$A_V = 1,$ $C_L = 100 \text{ pF}^{\ddagger}$	25°C		30			30		kHz
φm	Phase margin at unity gain	$R_L = 50 \text{ k}\Omega^{\ddagger}$ ,	C <sub>L</sub> = 100 pF‡	25°C		63°	·		63°		
	Gain margin			25°C		15			15		dB

<sup>†</sup> Full range is –40°C to 125°C for Q suffix. ‡ Referenced to 2.5 V



SGLS216 - NOVEMBER 2003

# electrical characteristics at specified free-air temperature, $V_{DD\pm}$ = $\pm 5$ V (unless otherwise noted)

	DADAMETED	TEST OF	NUDITIONS	- +	TL	C2252-E	Р	TLC	C2252A-	EP	
	PARAMETER	IESI CC	ONDITIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
.,	land offertual to a			25°C		200	1500		200	850	.,
V <sub>IO</sub>	Input offset voltage			Full range			1750			1000	μV
αΝΙΟ	Temperature coefficient of input offset voltage	]		25°C to 125°C		0.5			0.5		μV/°C
	Input offset voltage long- term drift (see Note 4)	$V_{IC} = 0,$ RS = 50 $\Omega$	$V_{O} = 0,$	25°C		0.003			0.003		μV/mo
				25°C		0.5	60		0.5	60	
ΙO	Input offset current			Full range			1000			1000	pА
				25°C		1	60		1	200 850 μV 1000 μV 0.5 μV/°C 003 μV/mC 0.5 60 pA 1000 pA 1 60 pA 1000 pA 4.2 V 1000 pA 4.98 4.99 4.91 V 1000 pA 150 pA 1	
I <sub>IB</sub>	Input bias current			Full range			1000				pА
	Common-mode input			25°C	-5 to 4	-5.3 to 4.2		-5 to 4			
VICR	voltage range	$R_S = 50 \Omega$ ,	g = -20 μA	Full range	-5 to 3.5			-5 to 3.5			V
		$I_0 = -20 \mu A$		25°C		4.98			4.98		
.,	Maximum positive peak			25°C	4.9	4.93		4.9	4.93		.,
VOM+	output voltage	$I_{O} = -100 \mu$	Α	Full range	4.7			4.7			V
		$I_0 = -200  \mu$	Α	25°C	4.8	4.86		4.8	4.86		
		V <sub>IC</sub> = 0,	I <sub>O</sub> = 50 μA	25°C		-4.99			-4.99		
		., -		25°C	-4.85	-4.91		-4.85	-4.91		
VoM−	Maximum negative peak output voltage	$V_{IC} = 0$ ,	I <sub>O</sub> = 500 μA	Full range	-4.85			-4.85			V
	peak output voltage	., .		25°C	-4	-4.3		-4	-4.3		
		$V_{IC} = 0$ ,	$I_O = 4 \text{ mA}$	Full range	-3.8			-3.8			
			B 40010	25°C	40	150		40	150		
$A_{VD}$	Large-signal differential voltage amplification	V <sub>O</sub> = ±4 V	$R_L = 100 \text{ k}\Omega$	Full range	10			10			V/mV
	voltage amplification		$R_L = 1 M\Omega$	25°C		3000			3000		
r <sub>id</sub>	Differential input resistance			25°C		10 <sup>12</sup>			10 <sup>12</sup>		Ω
r <sub>ic</sub>	Common-mode input resistance			25°C		1012			1012		Ω
c <sub>ic</sub>	Common-mode input capacitance	f = 10 kHz,	P package	25°C		8			8		pF
z <sub>O</sub>	Closed-loop output impedance	f = 25 kHz,	A <sub>V</sub> = 10	25°C		190			190		Ω
CMRR	Common-mode rejection ratio	$V_{IC} = -5 \text{ V t}$ $V_{O} = 0$	o 2.7 V, R <sub>S</sub> = 50 Ω	25°C Full range	75 75	88		75 75	88		dB
	<u> </u>			25°C	80	95		80	95		
ksvr	Supply-voltage rejection ratio $(\Delta V_{DD\pm}/\Delta V_{IO})$	$V_{DD} = \pm 2.2$ V <sub>IC</sub> = 0,	v to ±8 v, No load	Full range	80			80	- 55		dB
	, DD±, IO/	10 - 7		25°C	- 00	80	125	- 00	80	125	
lDD	Supply current	$V_0 = 2.5 V$	No load	Full range		00	150		00	150	μΑ

<sup>†</sup> Full range is –40°C to 125°C for Q suffix.

NOTE 4: Typical values are based on the input offset voltage shift observed through 500 hours of operating life test at  $T_A = 150^{\circ}C$  extrapolated to  $T_A = 25^{\circ}C$  using the Arrhenius equation and assuming an activation energy of 0.96 eV.



### TLC225x-EP, TLC225xA-EP Advanced LinCMOS™ RAIL-TO-RAIL VERY LOW-POWER OPERATIONAL AMPLIFIERS

SGLS216 - NOVEMBER 2003

# operating characteristics at specified free-air temperature, $V_{DD\pm}$ = $\pm 5~\text{V}$

	DADAMETED	TEST SON	DITIONS	- +	TLO	C2252-E	P	TLC	2252A-I	EP	LINUT
	PARAMETER	TEST CON	DITIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
		V 10V	D 40010	25°C	0.07	0.12		0.07	0.12		
SR	Slew rate at unity gain	$V_O = \pm 2 \text{ V},$ $C_L = 100 \text{ pF}$	$R_L = 100 \text{ k}\Omega$ ,	Full range	0.05			0.05			V/μs
.,	Equivalent input noise	f = 10 Hz		25°C		38			38		nV/√ <del>Hz</del>
Vn	voltage	f = 1 kHz		25°C		19			19		NV/√HZ
\/	Peak-to-peak equivalent	f = 0.1 Hz to 1 Hz	Z	25°C		0.8			0.8		/
V <sub>N(PP)</sub>	input noise voltage	f = 0.1 Hz to 10 H	łz	25°C		1.1			1.1		μV
In	Equivalent input noise current			25°C		0.6			0.6		fA√Hz
	Total harmonic distortion	$V_0 = \pm 2.3 \text{ V},$	A <sub>V</sub> = 1			0.2%			0.2%		
THD + N	plus noise	$R_L = 50 \text{ k}\Omega$ , f = 10  kHz	A <sub>V</sub> = 10	25°C		1%			1%		
	Gain-bandwidth product	f =10 kHz, C <sub>L</sub> = 100 pF	$R_L = 50 \text{ k}\Omega$ ,	25°C		0.21			0.21		MHz
Вом	Maximum output-swing bandwidth	$V_{O(PP)} = 4.6 \text{ V},$ $R_{L} = 50 \text{ k}\Omega,$	A <sub>V</sub> = 1, C <sub>L</sub> = 100 pF	25°C		14			14		kHz
φm	Phase margin at unity gain	R <sub>L</sub> = 50 kΩ,	C <sub>L</sub> = 100 pF	25°C		63°			63°		
	Gain margin			25°C		15	·	·	15		dB

<sup>†</sup> Full range is –40°C to 125°C for Q suffix.



SGLS216 - NOVEMBER 2003

# electrical characteristics at specified free-air temperature, $V_{DD}$ = 5 V (unless otherwise noted)

	PARAMETER	TEST CON	DITIONS	T. †	TL	C2254-E	Р	TLO	C2254A-	EP	
	PARAMETER	TEST CON	DITIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
V. 0	Input offset voltage			25°C		200	1500		200	850	μV
V <sub>IO</sub>	input onset voltage			Full range			1750			1000	μν
αΛΙΟ	Temperature coefficient of input offset voltage			25°C to 125°C		0.5			0.5		μV/°C
	Input offset voltage long-term drift (see Note 4)	$V_{DD\pm} = \pm 2.5 \text{ V},$ $V_{O} = 0,$	$V_{IC} = 0,$ RS = 50 $\Omega$	25°C		0.003			0.003		μV/mo
IIO	Input offset current			25°C		0.5	60		0.5	60	pА
10	input onset current	]		125°C			1000			1000	РΑ
I <sub>IB</sub>	Input bias current			25°C		1	60		1	60	рA
'ID	input blub current			125°C			1000			1000	ρ'n
.,	Common-mode input			25°C	0 to 4	-0.3 to 4.2		0 to 4	-0.3 to 4.2		.,
VICR	voltage range	$R_S = 50 \Omega$ ,	V <sub>IO</sub>   ≤5 mV	Full range	0 to 3.5			0 to 3.5			V
		I <sub>OH</sub> = -20 μA		25°C		4.98			4.98		
V	High-level output	Jan. 75 A		25°C	4.9	4.94		4.9	4.94		V
VOH	voltage	I <sub>OH</sub> = -75 μA		Full range	4.8			4.8			V
		$I_{OH} = -150 \mu A$		25°C	4.8	4.88		4.8	4.88		
		$V_{IC} = 2.5 V,$	$I_{OL} = 50 \mu A$	25°C		0.01			0.01		
	Low-level output	V <sub>IC</sub> = 2.5 V,	I <sub>OL</sub> = 500 μA	25°C		0.09	0.15		0.09	0.15	
VOL	voltage	V <sub>1</sub> C = 2.0 v,		Full range			0.15			0.15	V
	•	V <sub>IC</sub> = 2.5 V,	$I_{OL} = 4 \text{ mA}$	25°C		0.8	1		0.7	1	
		10 =10 1,	-OL	Full range			1.2			1.2	
	Large-signal	V <sub>IC</sub> = 2.5 V,	$R_{L} = 100 \text{ k}\Omega^{\ddagger}$	25°C	100	350		100	350		
AVD	differential voltage amplification	$V_0 = 1 \text{ V to 4 V}$	_	Full range	10	4700		10	4700		V/mV
			$R_L = 1 M\Omega^{\ddagger}$	25°C		1700			1700		
r <sub>i(d)</sub>	Differential input resistance			25°C		10 <sup>12</sup>			10 <sup>12</sup>		Ω
r <sub>i(c)</sub>	Common-mode input resistance			25°C		1012			1012		Ω
c <sub>i(c)</sub>	Common-mode input capacitance	f = 10 kHz,	N package	25°C		8			8		pF
z <sub>O</sub>	Closed-loop output impedance	f = 25 kHz,	A <sub>V</sub> = 10	25°C		200			200		Ω
CMRR	Common-mode rejection ratio	$V_{IC} = 0 \text{ to } 2.7 \text{ V},$ $R_S = 50 \Omega$	V <sub>O</sub> = 2.5 V,	25°C Full range	70 70	83		70 70	83		dB
	Supply-voltage	-		25°C	80	95		80	95		
ksvr	rejection ratio (\(\DV)\DV)\(\DV)\)	$V_{DD} = 4.4 \text{ V to 1}$ $V_{IC} = V_{DD}/2$ ,	6 V, No load	Full range	80	90		80	90		dB
	Supply current			25°C		140	250		140	250	
IDD	(four amplifiers)	$V_0 = 2.5 V$ ,	No load	Full range			300			300	μΑ

<sup>†</sup> Full range is –40°C to 125°C for Q suffix.

NOTE 4: Typical values are based on the input offset voltage shift observed through 500 hours of operating life test at  $T_A = 150^{\circ}C$  extrapolated to  $T_A = 25^{\circ}C$  using the Arrhenius equation and assuming an activation energy of 0.96 eV.



<sup>‡</sup>Referenced to 2.5 V

### TLC225x-EP, TLC225xA-EP Advanced LinCMOS™ RAIL-TO-RAIL VERY LOW-POWER OPERATIONAL AMPLIFIERS

SGLS216 - NOVEMBER 2003

# operating characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

	ADAMETED	TEST SOUD	ITIONIO	- +	TLO	C2254-E	P	TLC	2254A-	EP	LINUT
"	ARAMETER	TEST COND	IIIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	36 19 0.7 1.1 0.6 0.2% 1% 0.2 30	MAX	UNIT
	Class nata at south	$V_{O} = 0.5 \text{ V to } 3.5 \text{ V},$		25°C	0.07	0.12		0.07	0.12		
SR	Slew rate at unity gain	$R_L = 100 \text{ k}\Omega^{\ddagger},$ $C_L = 100 \text{ pF}^{\ddagger}$		Full range	0.05			0.05			V/µs
.,	Equivalent input	f = 10 Hz		25°C		36			36		nV/√ <del>Hz</del>
Vn	noise voltage	f = 1 kHz		25°C		19			19		nv/√HZ
.,	Peak-to-peak	f = 0.1 Hz to 1 Hz		25°C		0.7			0.7		.,
V <sub>N(PP)</sub>	equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1			1.1		μV
In	Equivalent input noise current			25°C		0.6			0.6		fA/√ <del>Hz</del>
THD + N	Total harmonic	$V_O = 0.5 \text{ V to } 2.5 \text{ V},$ f = 20 kHz,	A <sub>V</sub> = 1	0E°C		0.2%			0.2%		
THD + N	distortion plus noise	$R_L = 50 \text{ k}\Omega^{\ddagger}$	A <sub>V</sub> = 10	25°C		1%			1%		
	Gain-bandwidth product	f = 50  kHz, $C_L = 100 \text{ pF}^{\ddagger}$	$R_L = 50 \text{ k}\Omega^{\ddagger}$ ,	25°C		0.2			0.2		MHz
ВОМ	Maximum output- swing bandwidth	$V_{O(PP)} = 2 V,$ $R_L = 50 \text{ k}\Omega^{\ddagger},$	$A_V = 1,$ $C_L = 100 \text{ pF}^{\ddagger}$	25°C		30			30		kHz
φm	Phase margin at unity gain	$R_L = 50 \text{ k}\Omega^{\ddagger}$ ,	C <sub>L</sub> = 100 pF‡	25°C		63°			63°		
	Gain margin			25°C		15			15		dB

<sup>†</sup> Full range is –40°C to 125°C for Q suffix.



<sup>‡</sup>Referenced to 2.5 V

SGLS216 - NOVEMBER 2003

### electrical characteristics at specified free-air temperature, $V_{DD\pm}$ = $\pm 5$ V (unless otherwise noted)

	DADAMETED	TEST CO	NULTIONS	- +	TL	C2254-E	P	TLC	C2254A-	EP	
	PARAMETER	IESI CO	ONDITIONS	T <sub>A</sub> †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
.,	lanut effect valte se			25°C		200	1500		200	850	/
V <sub>IO</sub>	Input offset voltage			Full range			1750			1000	μV
αΛΙΟ	Temperature coefficient of input offset voltage			25°C to 125°C		0.5			0.5		μV/°C
	Input offset voltage long-term drift (see Note 4)	$V_{IC} = 0,$ $R_S = 50 \Omega$	$V_O = 0$ ,	25°C		0.003			0.003		μV/mo
l. a	Input offeet ourrent			25°C		0.5	60		0.5	60	n 1
lio	Input offset current			125°C			1000			1000	pА
lin	Input bias current			25°C		1	60		1	60	nΛ
IIB	Input bias current			125°C			1000			1000	pA
V	Common-mode input	B 50.0	N 1<5 m)/	25°C	–5 to 4	-5.3 to 4.2		-5 to 4	-5.3 to 4.2		V
VICR	voltage range	$R_S = 50 \Omega$ , $ V_{IO}  \le 5 \text{ mV}$ $I_O = -20 \mu\text{A}$	Full range	-5 to 3.5			-5 to 3.5			V	
		$I_{O} = -20 \mu$	1	25°C		4.98			4.98		
.,	Maximum positive peak			25°C	4.9	4.93		4.9	4.93		.,
VOM+	output voltage	$I_{O} = -100 \mu$	А	Full range	4.7			4.7		96	V
		I <sub>O</sub> = -200 μ	A	25°C	4.8	4.86		4.8	4.86		
		V <sub>IC</sub> = 0,	I <sub>O</sub> = 50 μA	25°C		-4.99			-4.99		
			Iα = 500 μΔ	25°C	-4.85	-4.91		-4.85	-4.91		
VOM-	Maximum negative peak output voltage	$V_{IC} = 0$ ,	$I_{O} = 500  \mu A$	Full range	-4.85			-4.85			V
	output voltage	., .	1 4 4	25°C	-4	-4.3		-4	-4.3		
		$V_{IC} = 0$ ,	$I_O = 4 \text{ mA}$	Full range	-3.8			-3.8			
			D 400 LO	25°C	40	150		40	150		
AVD	Large-signal differential voltage amplification	V <sub>O</sub> = ±4 V	$R_L = 100 \text{ k}\Omega$	Full range	10			10			V/mV
	voltage amplification		$R_L = 1 M\Omega$	25°C		3000			3000		
r <sub>i(d)</sub>	Differential input resistance			25°C		1012			1012		Ω
r <sub>i(c)</sub>	Common-mode input resistance			25°C		1012			1012		Ω
<sup>C</sup> i(c)	Common-mode input capacitance	f = 10 kHz,	N package	25°C		8			8		pF
z <sub>0</sub>	Closed-loop output impedance	f = 25 kHz,	A <sub>V</sub> = 10	25°C		190			190		Ω
CMDD	Common-mode rejection	V <sub>IC</sub> = −5 V	to 2.7 V,	25°C	75	88		75	88		10
CMRR	ratio	$V_{O} = 0,$	$R_S = 50 \Omega$	Full range	75			75			dB
	Supply-voltage rejection	V <sub>DD+</sub> = ±2	.2 V to ±8 V,	25°C	80	95		80	95		
ksvr	ratio ( $\Delta V_{DD\pm}/\Delta V_{IO}$ )	$V_{IC} = V_{DD}$		Full range	80			80			dB
	Supply current	., .	No loo d	25°C		160	250		160	250	
lDD	(four amplifiers)	$V_{O} = 0$ ,	No load	Full range			300			300	μΑ

Full range is -40°C to 125°C for Q suffix.

NOTE 4: Typical values are based on the input offset voltage shift observed through 500 hours of operating life test at  $T_A = 150^{\circ}C$  extrapolated to  $T_A = 25^{\circ}C$  using the Arrhenius equation and assuming an activation energy of 0.96 eV.



### TLC225x-EP, TLC225xA-EP Advanced LinCMOS™ RAIL-TO-RAIL VERY LOW-POWER OPERATIONAL AMPLIFIERS

SGLS216 - NOVEMBER 2003

# operating characteristics at specified free-air temperature, $V_{DD\pm}$ = $\pm 5~\text{V}$

	242445752	TEOT 0011	DITIONS	T <sub>A</sub> †	TLO	TLC2254-EP TLC2254A-EP			EP	LINUT	
	PARAMETER		TEST CONDITIONS			TYP	MAX	MIN	TYP	MAX	UNIT
			D 40010	25°C	0.07	0.12		0.07	0.12		
SR	Slew rate at unity gain	$V_O = \pm 2 \text{ V},$ $C_L = 100 \text{ pF}$	$R_L = 100 \text{ k}\Omega,$	Full range	0.05			0.05			V/μs
.,	Equivalent input noise	f = 10 Hz	25°C	38			38			-> // <del>   </del>	
Vn	voltage	f = 1 kHz		25°C	19			19			nV/√Hz
.,	Peak-to-peak	f = 0.1 Hz to 1 Hz		25°C		8.0		0.8			
V <sub>N(PP)</sub>	equivalent input noise voltage	f = 0.1 Hz to 10 H	z	25°C	1.1				1.1		μV
In	Equivalent input noise current		25°C	0.6		0.6			fA/√ <del>Hz</del>		
TUD . N	Total harmonic	$V_0 = \pm 2.3 \text{ V},  A_V = 1$		0500	0.2%			0.2%			
THD + N	distortion plus noise	$R_L = 50 \text{ k}\Omega$ , f = 20 kHz	A <sub>V</sub> = 10	25°C		1%			1%		
	Gain-bandwidth product	f =10 kHz, C <sub>L</sub> = 100 pF	$R_L = 50 \text{ k}\Omega$ ,	25°C		0.21			0.21		MHz
ВОМ	Maximum output-swing bandwidth	$V_{O(PP)} = 4.6 \text{ V},$ $R_{L} = 50 \text{ k}\Omega,$	A <sub>V</sub> = 1, C <sub>L</sub> = 100 pF	25°C		14			14		kHz
φm	Phase margin at unity gain	R <sub>L</sub> = 50 kΩ,	C <sub>L</sub> = 100 pF	25°C		63°			63°		
	Gain margin			25°C		15			15		dB

<sup>†</sup> Full range is –40°C to 125°C for Q suffix.



### **Table of Graphs**

			FIGURE
V <sub>IO</sub>	Input offset voltage	Distribution vs Common-mode input voltage	2 – 5 6, 7
ανιο	Input offset voltage temperature coefficient	Distribution	8 – 11
I <sub>IB</sub> /I <sub>IO</sub>	Input bias and input offset currents	vs Free-air temperature	12
VI	Input voltage range	vs Supply voltage vs Free-air temperature	13 14
VOH	High-level output voltage	vs High-level output current	15
V <sub>OL</sub>	Low-level output voltage	vs Low-level output current	16, 17
V <sub>OM+</sub>	Maximum positive peak output voltage	vs Output current	18
V <sub>OM</sub> -	Maximum negative peak output voltage	vs Output current	19
V <sub>O(PP)</sub>	Maximum peak-to-peak output voltage	vs Frequency	20
los	Short-circuit output current	vs Supply voltage vs Free-air temperature	21 22
Vo	Output voltage	vs Differential input voltage	23, 24
	Differential gain	vs Load resistance	25
A <sub>VD</sub>	Large-signal differential voltage amplification	vs Frequency vs Free-air temperature	26, 27 28, 29
z <sub>O</sub>	Output impedance	vs Frequency	30, 31
CMRR	Common-mode rejection ratio	vs Frequency vs Free-air temperature	32 33
ksvr	Supply-voltage rejection ratio	vs Frequency vs Free-air temperature	34, 35 36
I <sub>DD</sub>	Supply current	vs Supply voltage vs Free-air temperature	37 38
SR	Slew rate	vs Load capacitance vs Free-air temperature	39 40
VO	Inverting large-signal pulse response		41, 42
VO	Voltage-follower large-signal pulse response		43, 44
VO	Inverting small-signal pulse response		45, 46
VO	Voltage-follower small-signal pulse response		47, 48
Vn	Equivalent input noise voltage	vs Frequency	49, 50
	Noise voltage (referred to input)	Over a 10-second period	51
	Integrated noise voltage	vs Frequency	52
THD + N	Total harmonic distortion plus noise	vs Frequency	53
	Gain-bandwidth product	vs Free-air temperature vs Supply voltage	54 55
фm	Phase margin	vs Frequency vs Load capacitance	26, 27 56
A <sub>m</sub>	Gain margin	vs Load capacitance	57
B <sub>1</sub>	Unity-gain bandwidth	vs Load capacitance	58
<u> </u>	Overestimation of phase margin	vs Load capacitance	59



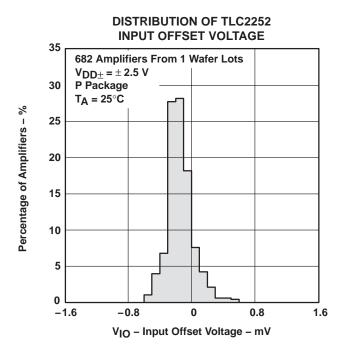
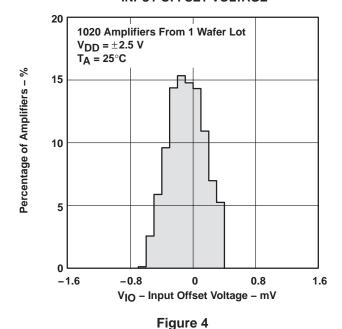


Figure 2

# DISTRIBUTION OF TLC2254 INPUT OFFSET VOLTAGE



DISTRIBUTION OF TLC2252

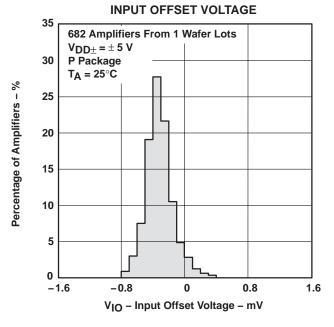


Figure 3

# DISTRIBUTION OF TLC2254 INPUT OFFSET VOLTAGE

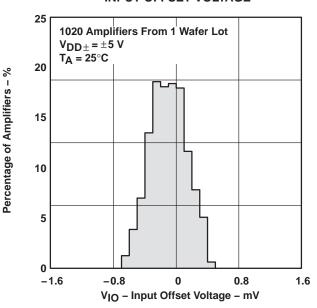
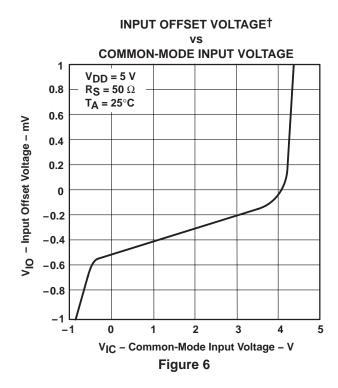
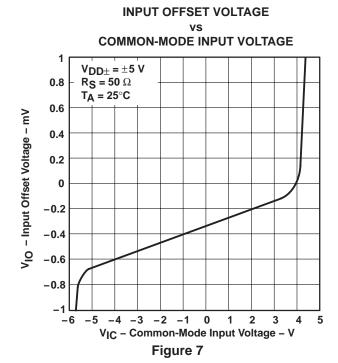
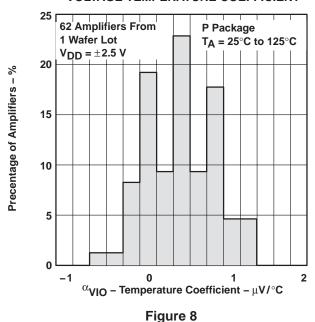


Figure 5





# DISTRIBUTION OF TLC2252 INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT



# DISTRIBUTION OF TLC2252 INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT

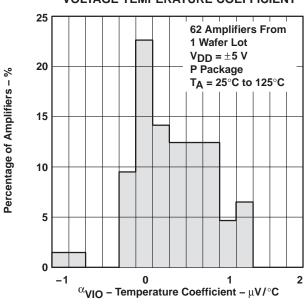


Figure 9

 $\dagger$  For curves where  $V_{DD}$  = 5 V, all loads are referenced to 2.5 V.



# 

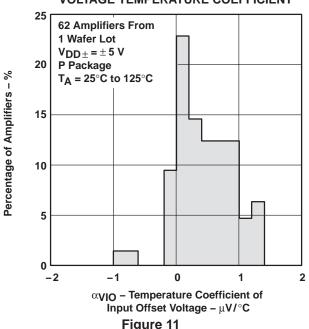
### Figure 10

INPUT BIAS AND INPUT OFFSET CURRENTS†

### FREE-AIR TEMPERATURE IB and I<sub>IO</sub> - Input Bias and Input Offset Currents - pA 35 $V_{DD\pm}$ = ±2.5 VVIC = 030 $V_O = 0$ $R_S = 50 \Omega$ 25 **IIB** 20 15 llO 10 5 o t 25 85 125 $T_A$ – Free-Air Temperature – $^{\circ}C$

Figure 12

# DISTRIBUTION OF TLC2254 INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT



# INPUT VOLTAGE RANGE vs SUPPLY VOLTAGE

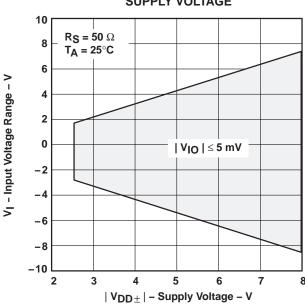


Figure 13

<sup>†</sup> Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



HIGH-LEVEL OUTPUT VOLTAGE†‡

### **TYPICAL CHARACTERISTICS**

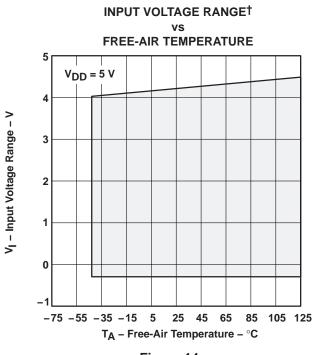


Figure 14

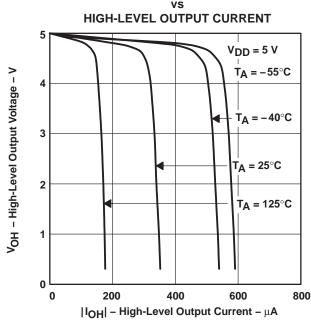
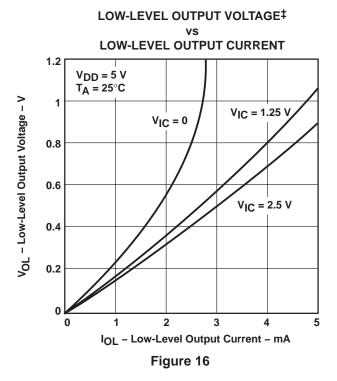


Figure 15





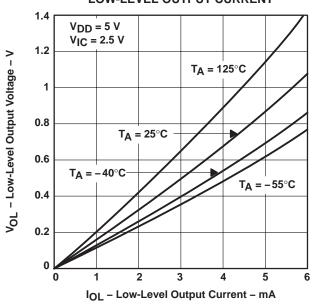


Figure 17

<sup>†</sup>Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

 $<sup>\</sup>ddagger$  For curves where  $V_{DD} = 5$  V, all loads are referenced to 2.5 V.

VOM + - Maximum Positive Peak Output Voltage - V

### TYPICAL CHARACTERISTICS

# MAXIMUM POSITIVE PEAK OUTPUT VOLTAGE<sup>†</sup> **OUTPUT CURRENT** 3 T<sub>A</sub> = 25°C $T_A = -40^{\circ}C$ 2 T<sub>A</sub> = 125°C $T_A = -55^{\circ}C$

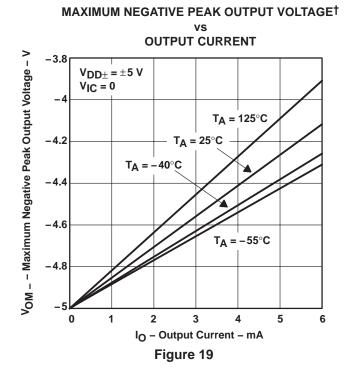
Figure 18

 $V_{DD} = \pm 5 V$ 

200

0

0



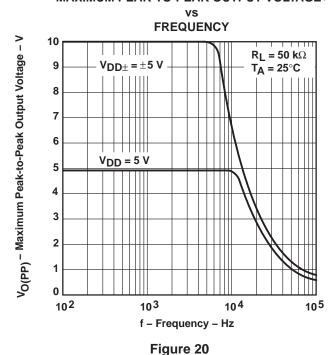
### MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE‡

400

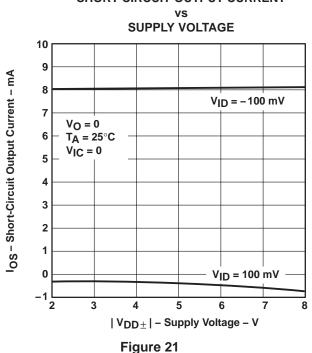
IO - Output Current - μA

600

800



### SHORT-CIRCUIT OUTPUT CURRENT



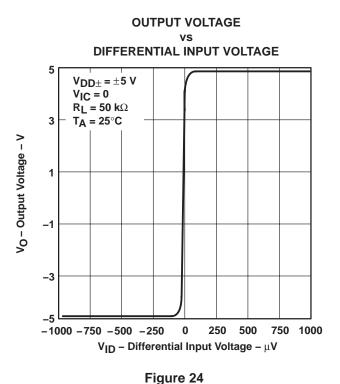
<sup>†</sup> Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

<sup>‡</sup> For curves where  $V_{DD} = 5 \text{ V}$ , all loads are referenced to 2.5 V.



### SHORT-CIRCUIT OUTPUT CURRENT<sup>†</sup> FREE-AIR TEMPERATURE 11 $V_O = 0$ 10 $V_{DD}\pm = \pm 5 V$ IOS - Short-Circuit Output Current - mA 9 $V_{ID} = -100 \text{ mV}$ 8 7 6 $V_{ID} = 100 \text{ mV}$ 0 -75 -50 50 100 -25 25 75 125 T<sub>A</sub> - Free-Air Temperature - °C

Figure 22



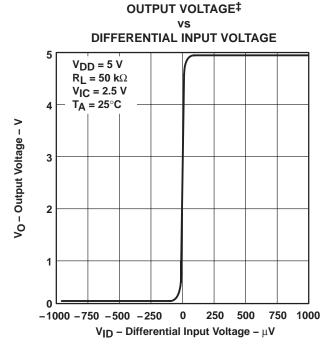


Figure 23

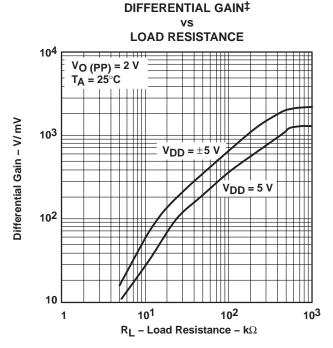


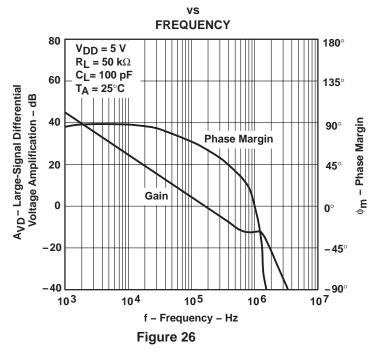
Figure 25

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

<sup>‡</sup> For curves where  $V_{DD} = 5 \text{ V}$ , all loads are referenced to 2.5 V.



### LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE MARGIN<sup>†</sup>



### LARGE-SIGNAL DIFFERENTIAL VOLTAGE **AMPLIFICATION AND PHASE MARGIN**

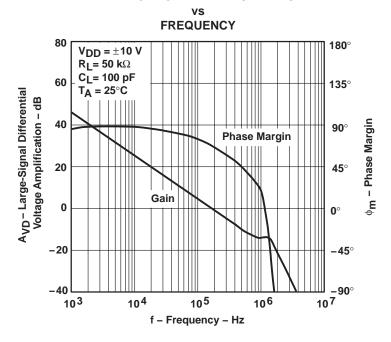


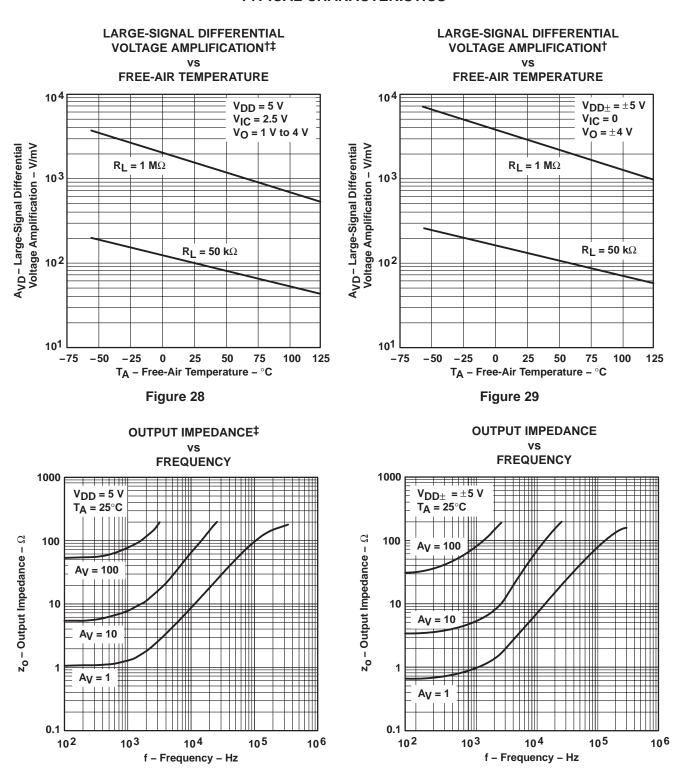
Figure 27

<sup>†</sup> For curves where  $V_{DD} = 5 \text{ V}$ , all loads are referenced to 2.5 V.



Figure 31

### TYPICAL CHARACTERISTICS

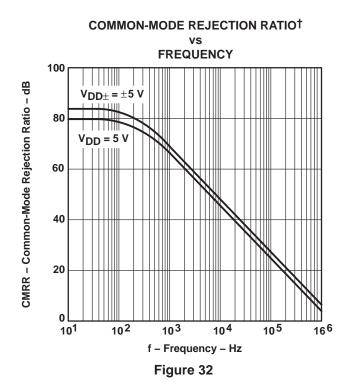


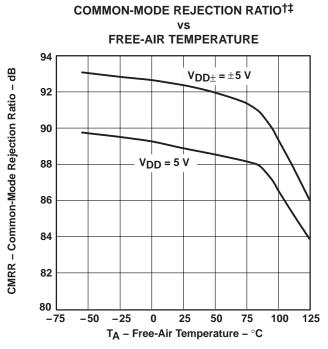
<sup>†</sup> Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

Figure 30



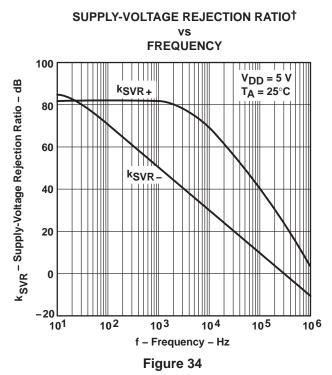
<sup>‡</sup> For curves where  $V_{DD} = 5 \text{ V}$ , all loads are referenced to 2.5 V.

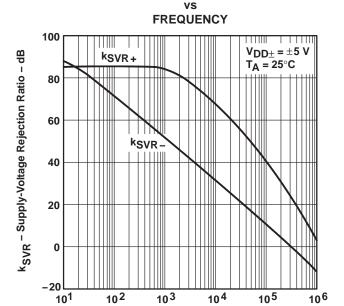




### Figure 33

SUPPLY-VOLTAGE REJECTION RATIO





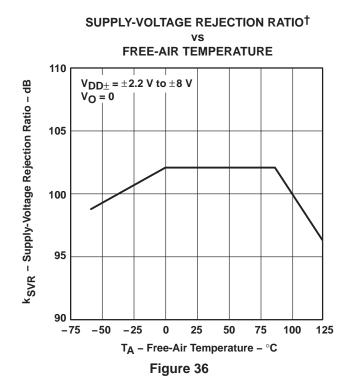
f - Frequency - Hz

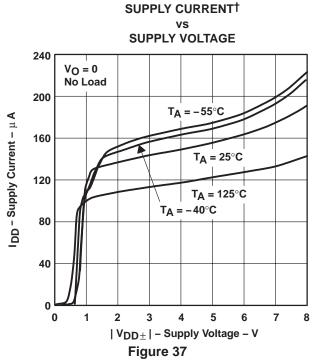
Figure 35

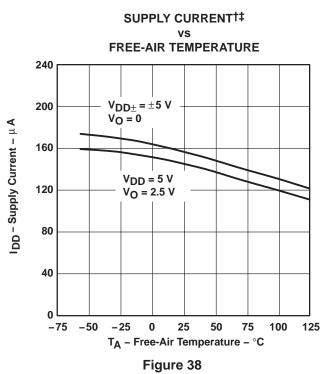
† For curves where  $V_{DD} = 5 \text{ V}$ , all loads are referenced to 2.5 V.

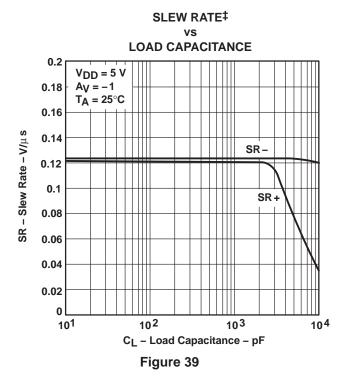
<sup>‡</sup> Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.







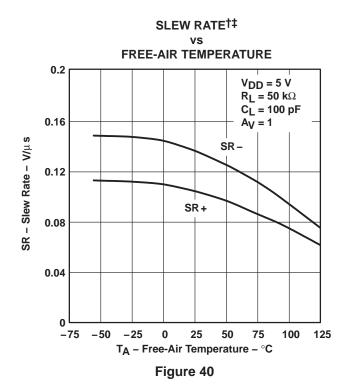


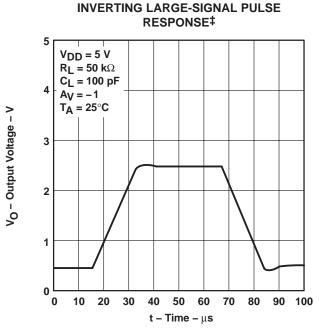


<sup>†</sup> Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

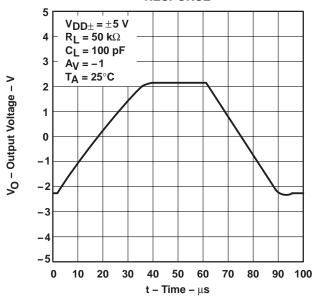
<sup>‡</sup> For curves where  $V_{DD} = 5 \text{ V}$ , all loads are referenced to 2.5 V.







# **INVERTING LARGE-SIGNAL PULSE RESPONSE**



**VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE**‡

Figure 41

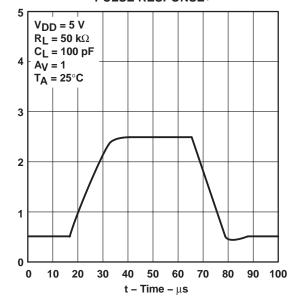


Figure 42

Figure 43

<sup>‡</sup> For curves where  $V_{DD} = 5 \text{ V}$ , all loads are referenced to 2.5 V.



V<sub>O</sub> - Output Voltage - V

<sup>†</sup> Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

# VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE

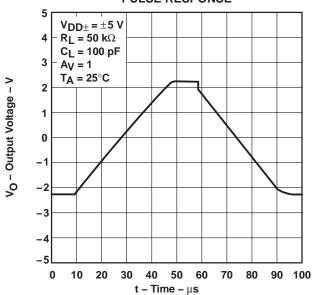


Figure 44

# INVERTING SMALL-SIGNAL PULSE RESPONSE

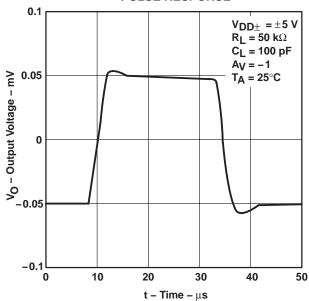


Figure 46

# INVERTING SMALL-SIGNAL PULSE RESPONSE†

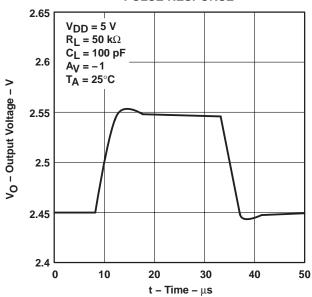


Figure 45

# VOLTAGE-FOLLOWER SMALL-SIGNAL PULSE RESPONSE†

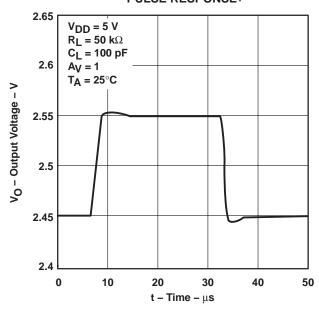


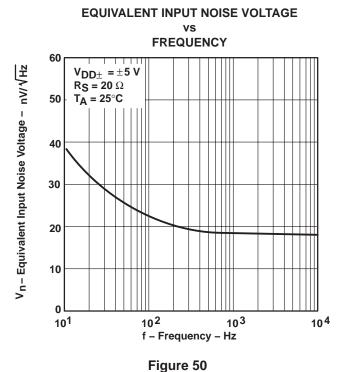
Figure 47

<sup>&</sup>lt;sup>†</sup> For curves where  $V_{DD}$  = 5 V, all loads are referenced to 2.5 V.



### **VOLTAGE-FOLLOWER SMALL-SIGNAL PULSE RESPONSE** 0.1 $V_{DD\pm} = \pm 5 V$ $R_L = 50 \text{ k}\Omega$ $C_L = 100 pF$ $A_V = 1$ T<sub>A</sub> = 25°C V<sub>O</sub> - Output Voltage - V - 0.00 0 0.00 0.05 -0.10 10 20 30 40 50 t – Time – $\mu$ s

Figure 48



 $\dagger$  For curves where  $V_{DD}$  = 5 V, all loads are referenced to 2.5 V.

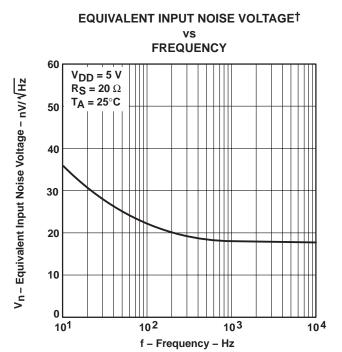


Figure 49

# EQUIVALENT INPUT NOISE VOLTAGE OVER A 10-SECOND PERIOD<sup>†</sup>

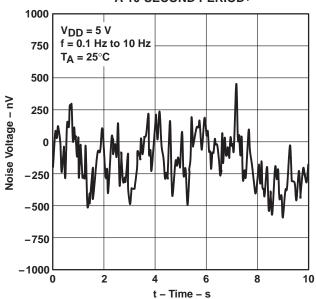


Figure 51



# INTEGRATED NOISE VOLTAGE VS FREQUENCY Calculated Using Ideal Pass-Band Filter Low Frequency = 1 Hz TA = 25°C Ta = 25°C 10 0.1 1 101 102 103 104 105 f - Frequency - Hz

TOTAL HARMONIC DISTORTION PLUS NOISE<sup>†</sup>

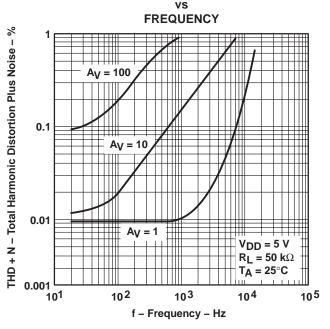
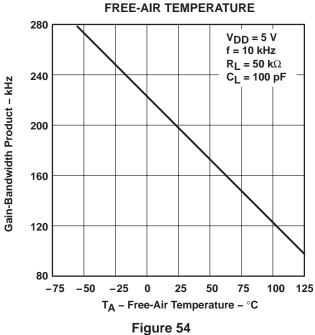


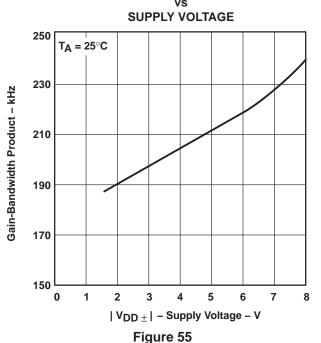
Figure 53



Figure 52



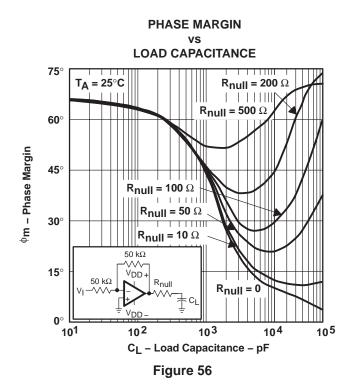
## GAIN-BANDWIDTH PRODUCT

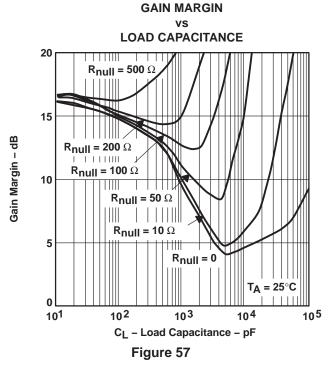


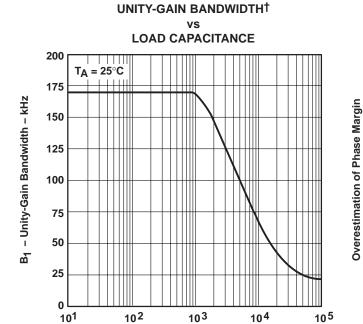
<sup>&</sup>lt;sup>†</sup> For curves where  $V_{DD} = 5 \text{ V}$ , all loads are referenced to 2.5 V.

<sup>‡</sup> Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.









C<sub>L</sub> - Load Capacitance - pF

Figure 58

# OVERESTIMATION OF PHASE MARGIN<sup>†</sup>

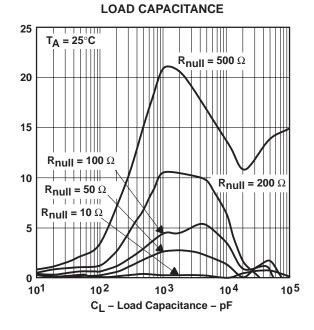


Figure 59



<sup>†</sup>See application information

SGLS216 - NOVEMBER 2003

### APPLICATION INFORMATION

### driving large capacitive loads

The TLC225x is designed to drive larger capacitive loads than most CMOS operational amplifiers. Figure 56 and Figure 57 illustrate its ability to drive loads up to 1000 pF while maintaining good gain and phase margins  $(R_{null} = 0)$ .

A smaller series resistor ( $R_{null}$ ) at the output of the device (see Figure 60) improves the gain and phase margins when driving large capacitive loads. Figure 56 and Figure 57 show the effects of adding series resistances of 10  $\Omega$ , 50  $\Omega$ , 100  $\Omega$ , 200  $\Omega$ , and 500  $\Omega$ . The addition of this series resistor has two effects: the first is that it adds a zero to the transfer function and the second is that it reduces the frequency of the pole associated with the output load in the transfer function.

The zero introduced to the transfer function is equal to the series resistance times the load capacitance. To calculate the improvement in phase margin, equation 1 can be used.

$$\Delta \phi_{m1} = \tan^{-1} \left( 2 \times \pi \times UGBW \times R_{null} \times C_{L} \right)$$
 (1)

Where:

 $\Delta \phi_{m1}$  = Improvement in phase margin UGBW = Unity-gain bandwidth frequency

R<sub>null</sub> = Output series resistance

C<sub>I</sub> = Load capacitance

The unity-gain bandwidth (UGBW) frequency decreases as the capacitive load increases (see Figure 58). To use equation 1, UGBW must be approximated from Figure 58.

Using equation 1 alone overestimates the improvement in phase margin, as illustrated in Figure 59. The overestimation is caused by the decrease in the frequency of the pole associated with the load, thus providing additional phase shift and reducing the overall improvement in phase margin.

Using Figure 60, with equation 1 enables the designer to choose the appropriate output series resistance to optimize the design of circuits driving large capacitance loads.

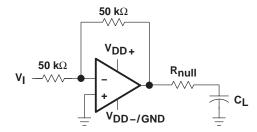


Figure 60. Series-Resistance Circuit

### **APPLICATION INFORMATION**

### macromodel information

Macromodel information provided was derived using MicroSim  $Parts^{TM}$ , the model generation software used with MicroSim  $PSpice^{TM}$ . The Boyle macromodel (see Note 5) and subcircuit in Figure 61 are generated using the TLC225x typical electrical and operating characteristics at  $T_A = 25$ °C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification

- Unity-gain frequency
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 4: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers", *IEEE Journal of Solid-State Circuits*, SC-9, 353 (1974).

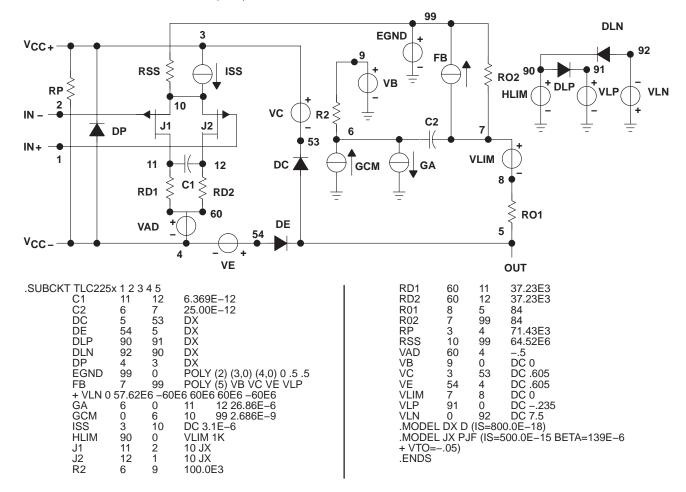


Figure 61. Boyle Macromodel and Subcircuit

PSpice and Parts are trademarks of MicroSim Corporation.







6-Feb-2020

### **PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
TLC2252AQDREP	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	2252AE	Samples
TLC2254AQDREP	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TLC2254AEP	Samples
V62/04682-02XE	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	2252AE	Samples
V62/04682-04YE	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-40 to 125	TLC2254AEP	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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### PACKAGE OPTION ADDENDUM

6-Feb-2020

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

### OTHER QUALIFIED VERSIONS OF TLC2252A-EP, TLC2254A-EP:

• Catalog: TLC2252A, TLC2254A

Automotive: TLC2252A-Q1, TLC2254A-Q1

Military: TLC2252AM, TLC2254AM

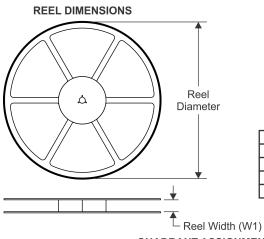
NOTE: Qualified Version Definitions:

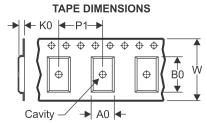
- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

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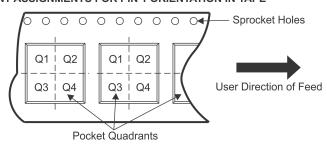
### TAPE AND REEL INFORMATION





Α0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TLC2252AQDREP	SOIC	D	8	2500	330.0	12.4	6.4	5.2	2.1	8.0	12.0	Q1
TLC2254AQDREP	SOIC	D	14	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1

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### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TLC2252AQDREP	SOIC	D	8	2500	367.0	367.0	35.0
TLC2254AQDREP	SOIC	D	14	2500	333.2	345.9	28.6

### D (R-PDSO-G14)

### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AB.



# D (R-PDSO-G14)

### PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.





SMALL OUTLINE INTEGRATED CIRCUIT



### NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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